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TEST REPORT

Applicant	:	SHARP CORPORATION, Consumer Electronics Company, Communication Systems Division
Address	:	2-13-1, Iida Hachihonmatsu, Higashi-Hiroshima City, Hiroshima, 739-0192, Japan
Products	:	Smart Phone
Model No.	:	SH-02J
Serial No.	:	004401115841278
		004401115841302
FCC ID	:	APYHRO00242
Test Standard	:	CFR 47 FCC Rules and Regulations Part 22
Test Results	:	Passed
Date of Test	:	August 18 ~ September 1, 2016



Kousei Shibata Manager Japan Quality Assurance Organization KITA-KANSAI Testing Center SAITO EMC Branch 7-3-10, Saito-asagi, Ibaraki-shi, Osaka 567-0085, Japan

- The test results in this test report was made by using the measuring instruments which are traceable to national standards of measurement in accordance with ISO/IEC 17025.
- The applicable standard, testing condition and testing method which were used for the tests are based on the request of the applicant.
- The test results presented in this report relate only to the offered test sample.
- The contents of this test report cannot be used for the purposes, such as advertisement for consumers.
- This test report shall not be reproduced except in full without the written approval of JQA.
- $\bullet~$ VLAC does not approve, certify or warrant the product by this test report.

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DEFINITIONS FOR ABBREVIATION AND SYMBOLS USED IN THIS TEST REPORT

- $\textbf{EUT} \quad : \text{Equipment Under Test}$
- **AE** : Associated Equipment
- N/A : Not Applicable
- N/T : Not Tested

- **EMC** : Electromagnetic Compatibility
- **EMI** : Electromagnetic Interference
- **EMS** : Electromagnetic Susceptibility
- \square indicates that the listed condition, standard or equipment is applicable for this report.
- \Box indicates that the listed condition, standard or equipment is not applicable for this report.



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1 Description of the Equipment Under Test

1.	Manufacturer	:	SHARP CORPORATION, Consumer Electronics Company,Communication Systems Division2-13-1, Iida Hachihonmatsu, Higashi-Hiroshima City, Hiroshima,739-0192, Japan
2.	Products	:	Smart Phone
3.	Model No.	:	SH-02J
4.	Serial No.	:	004401115841278
			004401115841302
5.	Product Type	:	Pre-production
6.	Date of Manufacture	:	June, 2016
7.	Power Rating	:	4.0VDC (Lithium-ion Battery UBATIA273AFN1 2700mAh)
8.	Grounding	:	None
9.	Transmitting Frequency	:	824.2 MHz(128CH) – 848.8 MHz(251CH)
10.	Receiving Frequency	:	869.2 MHz(128CH) – 893.8 MHz(251CH)
11.	Emission Designations	:	243KGXW
12.	Max. RF Output Power	:	1.585W (ERP)
13.	Category	:	GSM850
14.	EUT Authorization	:	Certification
15.	Received Date of EUT	:	August 1, 2016

16. Channel Plan

The carrier spacing is 200 kHz.

The carrier frequency is designated by the absolute frequency channel number (ARFCN). The carrier frequency is expressed in the equation shown as follows:

Transmitting Frequency (in MHz) = $824.2 + 0.2 \times (n - 128)$ where, n : channel number ($128 \le n \le 251$)

Receiving Frequency (in MHz) $= 869.2 + 0.2 \times (n$ –128) where, n : channel number (128 \leq n \leq 251)



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2 Summary of Test Results

Applied Standard : CFR 47 FCC Rules and Regulations Part 22 Subpart H – Cellular Radiotelephone Service

The EUT described in clause 1 was tested according to the applied standard shown above. Details of the test configuration is shown in clause 6.

The conclusion for the test items of which are required by the applied standard is indicated under the test result.

 \boxdot - The test result was **passed** for the test requirements of the applied standard.

 \Box - The test result was **failed** for the test requirements of the applied standard.

 \Box - The test result was **not judged** the test requirements of the applied standard.

In the approval of test results,

- Determining compliance with the limits in this report was based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.
- No deviations were employed from the applied standard.
- No modifications were conducted by JQA to achieve compliance to the limitations.

Reviewed by:

Shigeru Kinoshita Assistant Manager JQA KITA-KANSAI Testing Center SAITO EMC Branch

Tested by:

higen Osawa

Shigeru Osawa Deputy Manager JQA KITA-KANSAI Testing Center SAITO EMC Branch



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3 Test Procedure

Test Requirements	:	CFR 47 FCC Rules and Regulations Part 2 §2.1046, §2.1047, §2.1049, §2.1051, §2.1053, §2.1055 and §2.1057
Test Procedure	:	ANSI/TIA–603-D-2010 FCC KDB 971168 D01 Power Meas License Digital Systems v02r02, released October 17, 2014

4 Test Location

Japan Quality Assurance Organization (JQA) KITA-KANSAI Testing Center 7-7, Ishimaru, 1-chome, Minoh-shi, Osaka, 562-0027, Japan SAITO EMC Branch 7-3-10, Saito-asagi, Ibaraki-shi, Osaka 567-0085, Japan

5 Recognition of Test Laboratory

JQA KITA-KANSAI Testing Center SAITO EMC Branch is accredited under ISO/IEC 17025 by following accreditation bodies and the test facility is registered by the following bodies.

VLAC Accreditation No.	:	VLAC-001-2 (Expiry date : March 30, 2018)
VCCI Registration No.	:	A-0002 (Expiry date : March 30, 2018)
BSMI Registration No.	:	SL2-IS-E-6006, SL2-IN-E-6006, SL2-R1/R2-E-6006, SL2-A1-E-6006
		(Expiry date : September 14, 2016)
IC Registration No.	:	2079E-3, 2079E-4 (Expiry date : July 16, 2017)

Accredited as conformity assessment body for Japan electrical appliances and material law by METI. (Expiry date : February 22, 2019)



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6 Description of Test Setup

6.1 Test Configuration

The equipment under test (EUT) consists of :

	Item	Manufacturer	Model No.	Serial No.	FCC ID
А	Smart Phone	Sharp	SH-02J	004401115841278 *1) 004401115841302 *2)	APYHRO00242
В	AC Adapter	Fujitsu Corporation	05	YKA	N/A
С	Stereo Handsfree	Sharp	SHLDL1		N/A

*1) Used for Field Strength of Spurious Emission

*2) Used for Antenna Conducted Emission and Frequency Stability

The auxiliary equipment used for testing :

None

Type of Cable:

No.	Decomintion	Identification	Connector	Cable	Ferrite	Length
INO.	Description	(Manu. etc.)	Shielded	Shielded	Core	(m)
1	USB conversion cable			NO	YES	1.2
2	Handsfree Cable			NO	NO	1.5



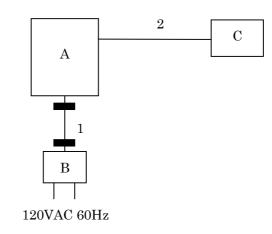
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6.2 Test Arrangement (Drawings)

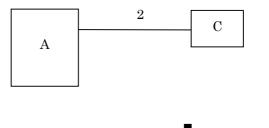
a) Single Unit



b) AC Adapter used



c) Earphone used



: Ferrite Core



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6.3 Operating Condition

Power Supply Voltage : 4.0 VDC (for Battery) 120 VAC, 60 Hz (For AC Adapter)

The test were carried under one modulation type shown as follows: Modulation Burst Signal : DATA TSC 5 in accordance with GSM 05.02. (Maximum Power Setting)

The Radiated Emission test were carried under 3 test configurations shown in clause 6.2. In all tests, the fully charged battery is used for the EUT.

Other Clock Frequency 19.2MHz, 48MHz, 12MHz, 27.12MHz

The EUT was rotated through three orthogonal axis (X, Y and Z axis) in radiated measurement. The EUT with temporary antenna port was used in conducted measurement.



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7 Test Requirements

7.0 Summary of the Test Results

Test Item	FCC Specification	Reference of the Test Report	Results	Remarks
RF Power Output	Section 22.913(a)(2)	Section 7.1	Passed	-
ERP / EIRP RF Power	Section 22.913(a)(2)	Section 7.2	Passed	-
Output				
Modulation Characteristics	-	-	-	-
Occupied Bandwidth	Section 22.917	Section 7.4	Passed	-
Spurious Emissions at	Section 22.917	Section 7.5	Passed	-
Antenna Terminals				
Band-Edge Emission	Section 22.917	Section 7.6	Passed	-
Field Strength of Spurious	Section 22.917	Section 7.7	Passed	-
Radiation				
Frequency Stability	Section 22.355	Section 7.8	Passed	-

7.1 RF Power Output (§2.1046)

For the requirements, \square - Applicable [\square - Tested. \square - Not tested by applicant request.] \square - Not Applicable

7.1.1 Test Results

For the standard,	\square - Passed	\Box - Failed	🗆 - Not j	udged			
Transmitter Power is		-	1667.2	mW	at	836.400	MHz
Uncertainty of Measure	ement Results					± 0.9	dB(2σ)

Remarks:



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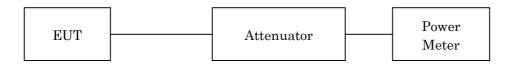
7.1.2 Test Instruments

Shielded Room S4									
Туре	Model	Serial No. (ID)	Manufacturer	Cal. Due					
Power Meter	N1911A	GB45100291 (B-63)	Agilent	2017/07/10					
Power Sensor	N1921A	US44510470 (B-64)	Agilent	2017/07/10					
Attenuator	43KC-20	1418003 (D-41)	Anritsu	2017/07/10					
RF Cable	SUCOFLEX102	14253/2 (C-52)	HUBER+SUHNER	2017/08/02					

NOTE : The calibration interval of the above test instruments is 12 months.

7.1.3 Test Method and Test Setup (Diagrammatic illustration)

The Conducted RF Power Output was measured with a power meter, one attenuator and a short, low loss cable.





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7.1.4 Test Data

(GSM850)

					<u>Date: August 18,</u> mp.: 27 °C, Humi:
Frans m	itting Frequency	Correction Factor	Meter Reading (Peak)	Result	s (Peak)
СН	[MHz]	[dB]	[dBm]	[dBm]	[mW]
128	824.200	20.35	11.84	32.19	1655.8
189	836.400	20.35	11.87	32.22	1667.2
251	848.800	20.35	11.85	32.20	1659.6
	d result at 836.400 M Correction Factor Meter Reading	IHz, as the maximum leve = 20.35 = 11.87	el point shown on underline: dB dBm		



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7.2 ERP / EIRP RF Power Output

For the requirements, \square - Applicable [\square - Tested. \square - Not tested by applicant request.] \square - Not Applicable

7.2.1 Test Results

For the standard,	\square - Passed	\Box - Failed	🗆 - Not	judged			
Min. Limit Margin			6.5	_ dB	at	836.400	MHz
Uncertainty of Measur	ement Results					± 1.6	$dB(2\sigma)$

Remarks: The maximum ERP is 1.585 W at 836.400 MHz. X-axis position.

7.2.2 Test Instruments

Anechoic Chamber A2							
Туре	Model	Serial No. (ID)	Manufacturer	Cal. Due			
Test Receiver	ESU 26	100170 (A-6)	Rohde & Schwarz	2016/04/25			
Signal Generator	E8257D	MY45140309 (B-39)	Agilent	2017/08/08			
Power Meter	N1911A	GB45100291 (B-63)	Agilent	2017/07/10			
Power Sensor	N1921A	US44510470 (B-64)	Agilent	2017/07/10			
Log-periodic Antenna	UHALP9108-A1	0694 (C-31)	Schwarzbeck	2017/05/18			
Attenuator (TX)	2-10	BA6214 (D-79)	Weinschel	2016/11/19			
Dipole Antenna (TX)	KBA-611	0-248-2 (C-20)	Kyoritsu	2017/05/24			

NOTE : The calibration interval of the above test instruments is 12 months.



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7.2.3 Test Method and Test Setup (Diagrammatic illustration)

Step 1:

In order to obtain the maximum emission, the EUT was placed at the height 1.5 m on the non-conducted support and was varying at three orthogonal axes, at the distance 3 m from the receiving antenna and rotated around 360 degrees.

The receiving antenna height was varied from 1 m to 4 m.

The EUT on the table was placed to be maximum emission against at the receiving antenna polarized (vertical and horizontal).

Then the meter reading of the spectrum analyzer at the maximum emission was A dB(μ V).

Step 2:

The EUT was replaced to substitution antenna at the same polarized under the same condition as step 1.

The RF power was fed to the transmitting antenna through the RF amplifier from the signal generator.

In order to obtain the maximum emission level, the height of the receiving antenna was varied from 1 m to 4 m.

The level of maximum emission was A dB(μ V), same as the recorded level in the step 1.

Then the RF power into the substitution horn antenna was P (dBm).

The ERP/EIRP output power was calculated in the following equation.

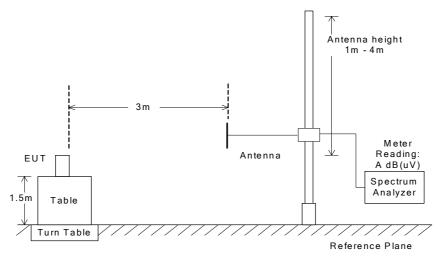
 $\begin{array}{l} {\rm ERP}\;({\rm dBm})={\rm P}\;({\rm dBm})-{\rm Balun\;loss\;of\;the\;tuned\;dipole\;antenna\;({\rm dB})+{\rm Cable\;loss\;({\rm dB})}\\ {\rm EIRP}\;({\rm dBm})={\rm P}\;({\rm dBm})+{\rm Gh\;({\rm dBi})} \end{array} \end{array}$

where, Gh(dBi): Gain of the substitution horn antenna.

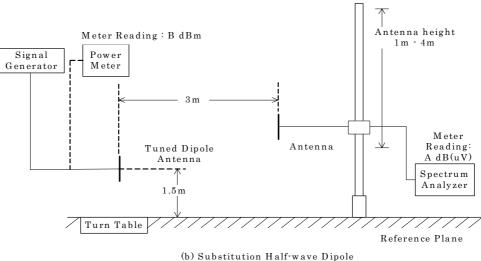


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o) Substitution Half-wave Dipol Antenna



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7.2.4 Test Data

(GSM850)

1	Measurement	Doculto
1.	wreasurement	Nesuus

<u>Test Date: August 24, 2016</u> <u>Temp.: 26 °C, Humi: 70 %</u>

	rans mitting Frequency	Emission Measurement [dB(uV)]		Substitution Measurement [dB(uV)]				Supplied Power to Substitution Antenna	Balun Loss of Substitution Antenna
СН	[MHz]	Hori. (Mh)	Vert. (Mv)	Hori. (Msh)	Vert. (Msv)	[dB m]	[dB]		
128	824.200	105.7	103.7	67.3	66.0	- 5.0	1.7		
189	836.400	105.6	103.0	66.8	65.8	- 5.0	1.8		
251	848.800	104.8	101.7	66.8	64.8	- 5.0	1.9		

2. Calculation Results

Transmi	tting Frequency	Peak ER	P [dBm]	Maximum Peak ERP	Limits	Margin
СН	[MHz]	Hori. (ERPh)	Vert. (ERPv)	[W]	[dB m]	[dB]
128	824.200	31.7	31.0	1.479	38.5	+ 6.8
189	836.400	32.0	30.4	1.585	38.5	+ 6.5
251	848.800	31.1	30.0	1.288	38.5	+ 7.4

Emission Measurment (Mh)		=	105.6	dB(uV)
Substitution Measurement (Msh)	=	-66.8	dB(uV)
Supplied Power to Substitut	ion Antenna	=	-5.0	dBm
+) Balun Loss of Substitution	Antenna	=	-1.8	dB
Result (ERPh)		=	32.0	dBm = 1.585 W
Minimum Margin: 38.5 - 32.0 = 6.5 (dE	3)			
NOTE: Setting of measuring instrum	nent(s):			
			II D III	а т :
Detector Function	Resolu	tion B.W.	V.B.W.	Sweep Time



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7.3 Modulation Characteristics (§2.1047)

For the requirements, \Box - Applicable [\Box - Tested. \Box - Not tested by applicant request.] \Box - Not Applicable

7.4 Occupied Bandwidth (§2.1049)

For the requirements, \square - Applicable [\square - Tested. \square - Not tested by applicant request.] \square - Not Applicable

7.4.1 Test Results

For the standard,	\square - Passed	\Box - Failed	🗆 - Not judge	d		
The 99% Bandwidth is The 26dB Bandwidth i		-	<u>242.5</u> kH: 320.1 kH:		<u>824.200</u> 836.400	MHz MHz
Uncertainty of Measur	ement Results				± 0.9	<u>%(2</u> 0)

Remarks :



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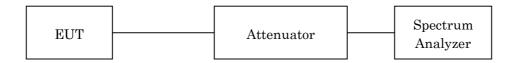
7.4.2 Test Instruments

Shielded Room S4							
Туре	Model	Serial No. (ID)	Manufacturer	Cal. Due			
Spectrum Analyzer	E4446A	US44300388 (A-39)	Agilent	2017/08/02			
Attenuator	43KC-20	1418003 (D-41)	Anritsu	2017/07/10			
RF Cable	SUCOFLEX102	14253/2 (C-52)	HUBER+SUHNER	2017/08/02			

NOTE : The calibration interval of the above test instruments is 12 months.

7.4.3 Test Method and Test Setup (Diagrammatic illustration)

The test system is shown as follows:



The setting of the spectrum analyzer are shown as follows:

Res. Bandwidth	$10 \mathrm{kHz}$
Video Bandwidth	$30 \mathrm{kHz}$
Span	1 MHz
Sweep Time	AUTO
Trace	Maxhold



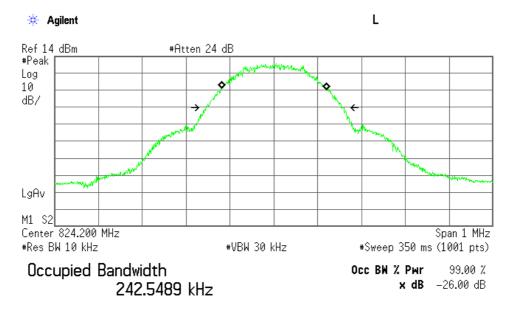
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7.4.4 Test Data

The resolution bandwidth was set to about 1% of emission bandwidth, -26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.

<u>Test Date :August 18, 2016</u> <u>Temp.:27°C, Humi:70%</u>

Channel	Frequency (MHz)	99% Bandwidth (kHz)	-26dBc Bandwidth (kHz)
128	824.20	242.5	317.4
189	836.40	241.7	320.1
251	848.80	242.3	314.2

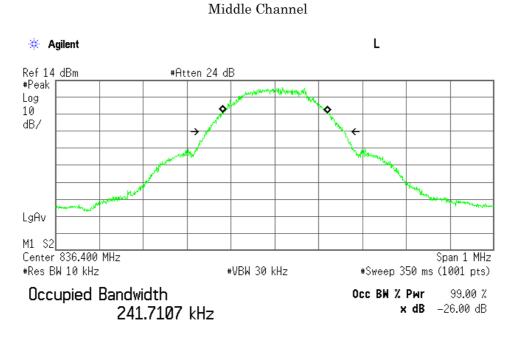


Low Channel

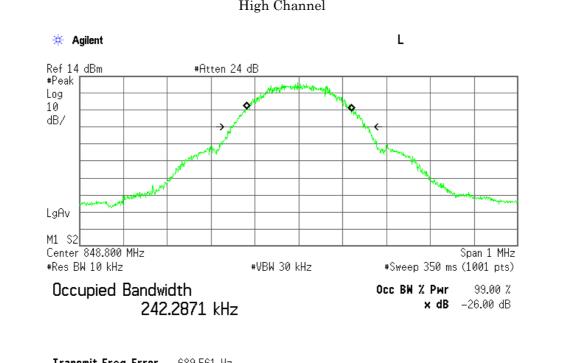
Transmit Freq Error	1.406 kHz
Occupied Bandwidth	317.441 kHz



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Transmit Freq Error	655.951 Hz
Occupied Bandwidth	320.127 kHz



High Channel

Technical document No. 23199-1601



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7.5 Spurious Emissions at Antenna Terminals (§2.1051)

For the requirements, \square - Applicable [\square - Tested. \square - Not tested by applicant request.] \square - Not Applicable

7.5.1 Test Results

For the standard,	\square - Passed	\Box - Failed	🗆 - Not j	judged			
Min. Limit Margin		-	29.9	_ dB	at	1648.400	MHz
Uncertainty of Measur	ement Results		1 GH	Hz – 1 (z – 18 (z – 40 (Hz		$\begin{array}{c} dB(2\sigma) \\ dB(2\sigma) \\ dB(2\sigma) \end{array}$

Remarks :

7.5.2 Test Instruments

Shielded Room S4								
Туре	Model Serial No. (ID) Ma		Manufacturer	Cal. Due				
Spectrum Analyzer	E4446A	US44300388 (A-39)	Agilent	2017/08/02				
Attenuator	43KC-20	1418003 (D-41)	Anritsu	2017/07/10				
RF Cable	SUCOFLEX102	14253/2 (C-52)	HUBER+SUHNER	2017/08/02				
High Pass Filter	HPM50108	010 (D-94)	MICRO-TRONICS	2017/02/17				

NOTE : The calibration interval of the above test instruments is 12 months.

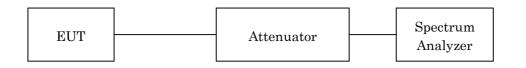


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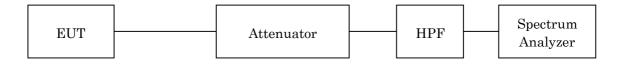
7.5.3 Test Method and Test Setup (Diagrammatic illustration)

The Antenna Conducted Emission was measured with a spectrum analyzer. The test system is shown as follows:

a) Frequency Range: 9 kHz – 1.2 GHz



b) Frequency Range: 1.2 GHz – 10 GHz



The setting of the spectrum analyzer are shown as follows:

Frequency Range	9 kHz - 150 kHz	150 kHz - 30 MHz	30 MHz - 10 GHz
Res. Bandwidth	200 Hz	$10 \mathrm{kHz}$	1 MHz
Video Bandwidth	1 kHz	30 kHz	$3 \mathrm{MHz}$
Sweep Time	AUTO	AUTO	AUTO
Trace	Maxhold	Maxhold	Maxhold



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7.5.4 Test Data

(GSM850)

 Test Date: August 18, 2016

 Temp.: 27 °C, Humi: 70 %

	ransmitting	Measured	Corr.	Meter Readings	Limits	Results	Margin	Remarks
	re que nc y	Frequency	Factor	[dBm]	[dBm]	[dBm]	[dB]	
СН	[MHz]	[MHz]	[dB]					
128	824.200	1648.400	21.6	-64.5	-13.0	-42.9	+29.9	С
		2472.600	21.3	-69.6	-13.0	-48.3	+35.3	С
		3296.800	21.4	< -70.0	-13.0	< -48.6	> +35.6	С
		4121.000	21.4	< -70.0	-13.0	< -48.6	> +35.6	С
		4945.200	21.6	< -70.0	-13.0	< -48.4	> +35.4	С
		5769.400	21.6	< -70.0	-13.0	< -48.4	> +35.4	С
		6593.600	21.8	< -70.0	-13.0	< -48.2	> +35.2	С
		7417.800	21.9	< -70.0	-13.0	< -48.1	> +35.1	С
		8242.000	22.1	< -70.0	-13.0	< -47.9	> +34.9	С
189	836.400	1672.800	21.5	-68.4	-13.0	-46.9	+33.9	С
		2509.200	21.2	-69.3	-13.0	-48.1	+35.1	С
		3345.600	21.4	< -70.0	-13.0	< -48.6	> +35.6	С
		4182.000	21.5	< -70.0	-13.0	< -48.5	> +35.5	С
		5018.400	21.6	< -70.0	-13.0	< -48.4	> +35.4	С
		5854.800	21.6	< -70.0	-13.0	< -48.4	> +35.4	С
		6691.200	21.8	< -70.0	-13.0	< -48.2	> +35.2	С
		7527.600	22.0	< -70.0	-13.0	< -48.0	> +35.0	С
		8364.000	22.2	< -70.0	-13.0	< -47.8	> +34.8	С
251	848.800	1697.600	21.5	-69.5	-13.0	-48.0	+35.0	С
		2546.400	21.2	-69.7	-13.0	-48.5	+35.5	С
		3395.200	21.4	< -70.0	-13.0	< -48.6	> +35.6	С
		4244.000	21.5	< -70.0	-13.0	< -48.5	> +35.5	С
		5092.800	21.6	< -70.0	-13.0	< -48.4	> +35.4	С
		5941.600	21.6	< -70.0	-13.0	< -48.4	> +35.4	С
		6790.400	21.8	< -70.0	-13.0	< -48.2	> +35.2	С
		7639.200	22.0	< -70.0	-13.0	< -48.0	> +35.0	С
		8488.000	22.2	< -70.0	-13.0	< -47.8	> +34.8	С



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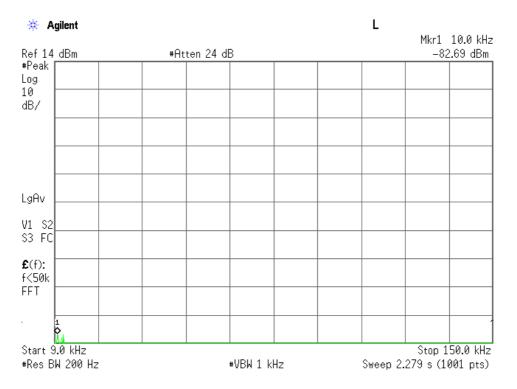
=	21.6 dB		
=	-64.5 dBm		
=	-42.9 dBm		
= 29.9 (dB)			
m 9 kHz to 10) GHz.		
10log(TP[mW]) - (43 + 10log(tp[W	$= 10\log(TP[mW]) - (43 + (10\log(TP[mW])))$	V]) - 30))
0	0.1-		
	ter power at antitena	terminai	
	r - 1 / r - r -		
ss + Pad Att.	[dB](9 kHz‐1.2 GH	<u>()</u>	
ss + Pad Att	+ High Pass Filter I	oss [dB] (over 1.2 GHz)	
ss + Pad Att ss".	+ High Pass Filter I	oss [dB] (over 1.2 GHz)	
	+ High Pass Filter I	oss [dB] (over 1.2 GHz)	
(= 29.9 (dB) m 9 kHz to 10 10log(TP[mW] 00 : Transmitt as follows:	= -42.9 dBm = 29.9 (dB) m 9 kHz to 10 GHz. 10log(TP[mW]) - (43 + 10log(tp[W])) 00 : Transmitter power at anttena to a stollows:	= -42.9 dBm = 29.9 (dB) m 9 kHz to 10 GHz. 10log(TP[mW]) - (43 + 10log(tp[W])) = 10log(TP[mW]) - (43 + (10 log(TP[mW 00 : Transmitter power at anttena terminal . as follows:

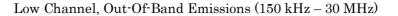
	Detector Function	RES B.W.	V.B.W.	Sweep Time
А	Peak	200 Hz	1 kHz	AUTO
В	Peak	10 kHz	30 kHz	AUTO
С	Peak	1 MHz	3 MHz	AUTO

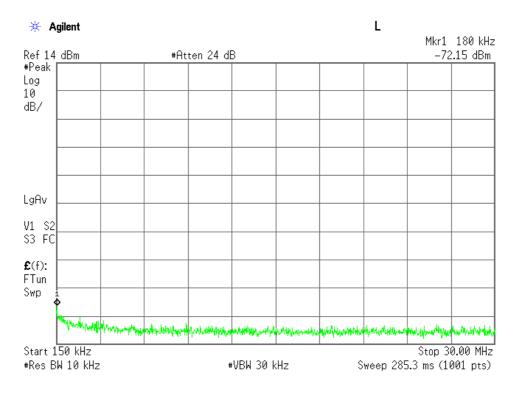


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Low Channel, Out-Of-Band Emissions (9 kHz - 150 kHz)



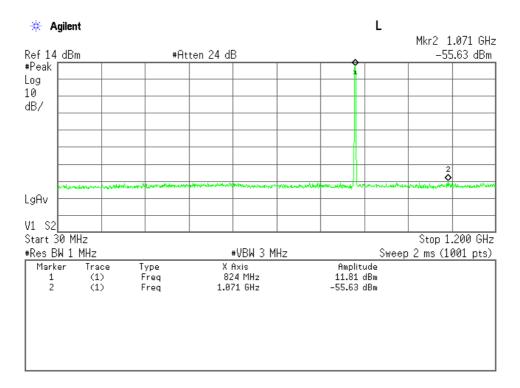




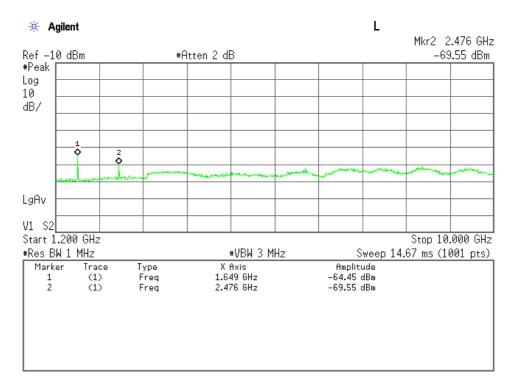


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Low Channel, Out-Of-Band Emissions (30 MHz – 1.2 GHz)



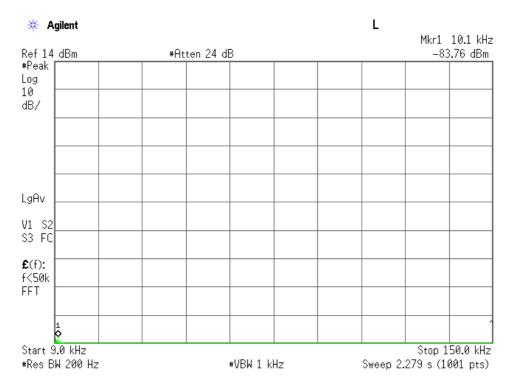
Low Channel, Out-Of-Band Emissions (1.2 GHz - 10 GHz)



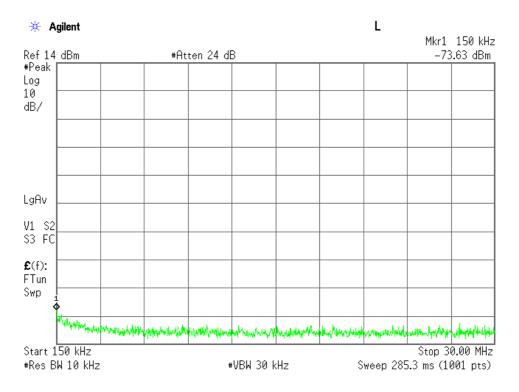


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Middle Channel, Out-Of-Band Emissions (9 kHz – 150 kHz)



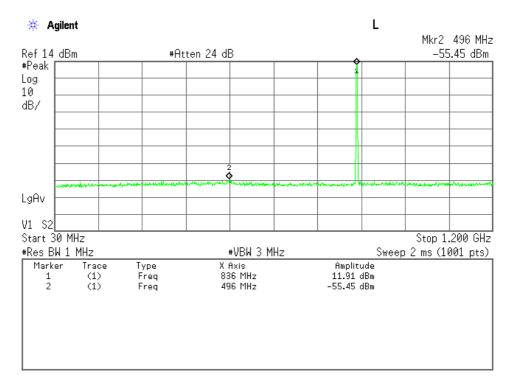




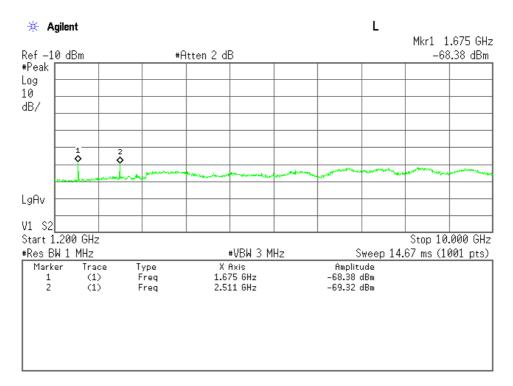


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Middle Channel, Out-Of-Band Emissions (30 $\rm MHz-1.2~GHz)$



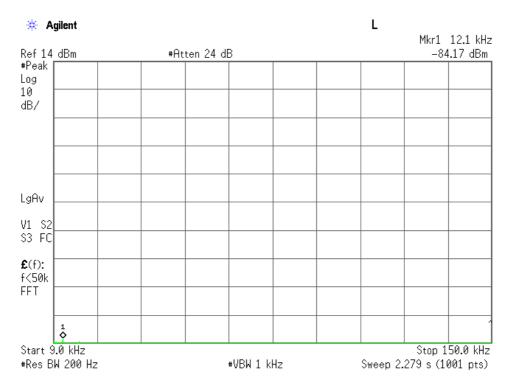
Middle Channel, Out-Of-Band Emissions (1.2 GHz - 10 GHz)

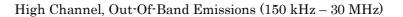


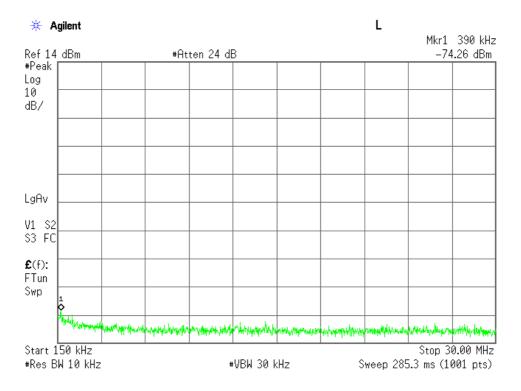


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High Channel, Out-Of-Band Emissions (9 kHz – 150 kHz)



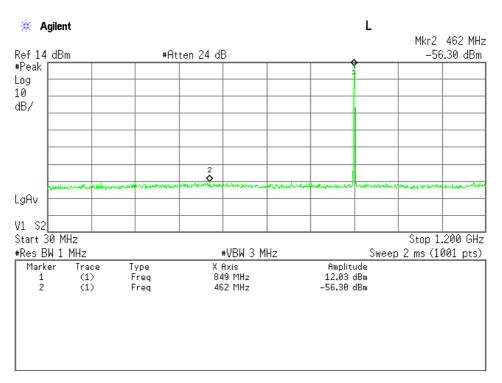




Technical document No. 23199-1601

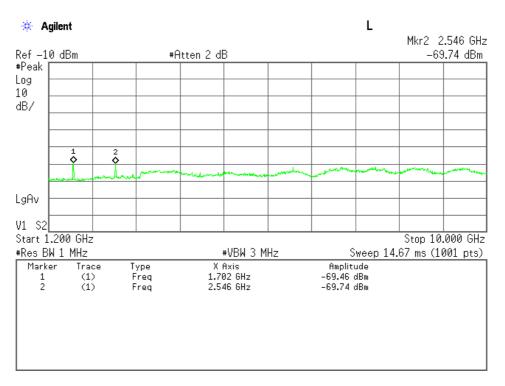


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High Channel, Out-Of-Band Emissions (30 MHz – 1.2 GHz)

High Channel, Out-Of-Band Emissions (1.2 GHz - 10 GHz)





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7.6 Band-Edge Emission (§2.1051)

For the requirements, \square - Applicable [\square - Tested. \square - Not tested by applicant request.] \square - Not Applicable

7.6.1 Test Results

For the standard,	\square - Passed	\Box - Failed	🗆 - Not j	udged			
Min. Limit Margin		-	1.1	dB	at _	849.0	MHz
The Band-Edge level is	3	-	-14.1	dBm	at _	849.0	MHz
Uncertainty of Measur	ement Results				_	± 1.4	dB(2σ)

Remarks: The measurement result is within the range of measurement uncertainty.

7.6.2 Test Instruments

Shielded Room S4								
Туре	Model	Serial No. (ID)	Manufacturer	Cal. Due				
Spectrum Analyzer	E4446A	US44300388 (A-39)	Agilent	2017/08/02				
Attenuator	43KC-20	1418003 (D-41)	Anritsu	2017/07/10				
RF Cable	SUCOFLEX102	14253/2 (C-52)	HUBER+SUHNER	2017/08/02				

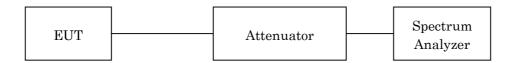
NOTE : The calibration interval of the above test instruments is 12 months.



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7.6.3 Test Method and Test Setup (Diagrammatic illustration)

The test system is shown as follows:



The setting of the spectrum analyzer are shown as follows:

TX Frequency	824.20 MHz / 848.80 MHz
Band-Edge Frequency	824.00 MHz / 849.00 MHz
Res. Bandwidth	$2.7~\mathrm{kHz}$
Video Bandwidth	$10 \mathrm{kHz}$
Span	2 MHz
Sweep Time	AUTO
Trace	Maxhold

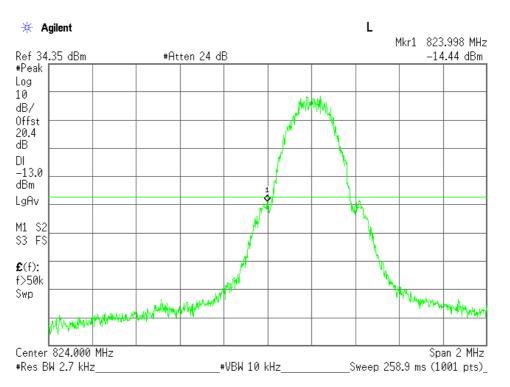


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7.6.4 Test Data

<u>Test Date :August 18, 2016</u> <u>Temp.:27°C, Humi:70%</u>

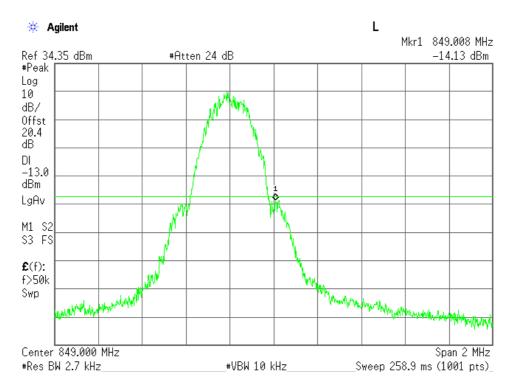
Channel	Frequency (MHz)	Band-Edge Frequency (MHz)	Band-Edge Level (dBm)	Limits (dBm)	Margin (dB)
128	824.0	824.0	-14.4	-13.0	+1.4
251	849.0	849.0	-14.1	-13.0	+1.1



Low Channel, Band-Edge Emission



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High Channel, Band-Edge Emission



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7.7 Field Strength of Spurious Radiation (§2.1053)

For the requirements, \square - Applicable [\square - Tested. \square - Not tested by applicant request.] \square - Not Applicable

7.7.1 Test Results

For the standard,	\square - Passed	\Box - Failed	🗆 - Not j	judged			
Min. Limit Margin			26.4	_ dB	at	2546.4	MHz
Uncertainty of Measurement Results			30 MHz – 1 GHz	1000 M z – 18 C		$\begin{array}{rrr} \pm 1.6 \\ \pm 1.8 \end{array}$	dB(2σ) dB(2σ)

Remarks: X-axis position



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7.7.2 Test Instruments

Anechoic Chamber A2								
		Manufacturer	Cal. Due					
Test Receiver	ESU 26	100170 (A-6)	Rohde & Schwarz	2017/04/27				
Signal Generator	E8257D	MY45140309 (B-39)	Agilent	2017/08/08				
Power Meter	N1911A	GB45100291 (B-63)	Agilent	2017/07/10				
Power Sensor	N1921A	US44510470 (B-64)	Agilent	2017/07/10				
Biconical Antenna	VHA9103/BBA9106	2355 (C-30)	Schwarzbeck	2017/05/18				
Log-periodic Antenna	UHALP9108-A1	0694 (C-31)	Schwarzbeck	2017/05/18				
Dipole Antenna (TX)	KBA-511A	0-273-2 (C-17)	Kyoritsu	2017/05/24				
Dipole Antenna (TX)	KBA-611	0-248-2 (C-20)	Kyoritsu	2017/05/24				
RF Cable	S 10162 B-11 etc.	(H-4)	HUBER+SUHNER	2017/04/03				
Pre-Amplifier	TPA0118-36	1010 (A-37)	ТОҮО	2017/05/17				
Horn Antenna	91888-2	562 (C-41-1)	EATON	2017/06/12				
Horn Antenna	91889-2	568 (C-41-2)	EATON	2017/06/12				
Horn Antenna	3160-04	9903-1053 (C-55)	EMCO	2017/06/13				
Horn Antenna	3160-05	9902-1061 (C-56)	EMCO	2017/06/13				
Horn Antenna	3160-06	9712-1045 (C-57)	EMCO	2017/06/13				
Horn Antenna	3160-07	9902-1113 (C-58)	EMCO	2017/06/13				
Attenuator	2-10	AW7937 (D-40)	Weinschel	2016/10/12				
Attenuator	54A-10	W5713 (D-29)	Weinschel	2017/08/02				
Attenuator	2-10	BA6214 (D-79)	Weinschel	2016/11/19				
RF Cable	SUCOFLEX102E	6683/2E (C-70)	HUBER+SUHNER	2016/11/19				
RF Cable	SUCOFLEX104	267479/4 (C-66)	HUBER+SUHNER	2017/01/06				
RF Cable	SUCOFLEX104	267414/4 (C-67)	HUBER+SUHNER	2017/01/06				
High Pass Filter	HPM50108	010 (D-94)	MICRO-TRONICS	2017/02/17				

NOTE : The calibration interval of the above test instruments is 12 months.



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7.7.3 Test Method and Test Setup (Diagrammatic illustration)

Step 1) The spurious radiation for transmitter were measured at the distance 3 m away from the EUT which was placed on a non-conducted support 0.8 m in height and was varying at three orthogonal axes. The receiving antenna was oriented for vertical polarization and varied from 1 m to 4 m until the maximum emission level was detected on the measuring instrument. The EUT was rotated 360 degrees until the maximum emission was received. The measurement was also repeated with the receiving antenna in the horizontal polarization.

This test was carried out using the half-wave dipole antenna for up to 1GHz and using the horn antenna for above 1 GHz.

Step 2)

A) Up to 1 GHz

The ERP measurement was carried out with according to Step 2 in Clause 7.2.3. Then the RF power in the substitution antenna half-wave dipole antenna for up to 1 GHz and the substitution horn antenna for above 1 GHz.

The ERP is calculated in the following equation.

ERP(dBm) = P(dBm) - (Balun Loss of the half-wave dipole Ant. (dB)) + Cable Loss (dB)

B) Above 1 GHz

The ERP is calculated from the maximum emission level by the following formula.

$$\frac{e^2}{120\pi} = \frac{eirp}{4\pi d^2} \quad \dots (\text{Eq.1})$$

 $erp = eirp - Gd \cdots (Eq.2)$

Where, e[V/m]: Field Strength at measuring distance(d=3m)

eirp[W]: Equivalent Isotropic Radiated Power

erp[*W*] : Effective Radiated Power

Gd(dBi): Gain of the substitution half-wave dipole antenna(2.15dBi)

$$eirp = \frac{(de)^2}{30} = \frac{3}{10}e^2$$

$$\therefore 10 \log(eirp) = 20 \log(e) + 10 \log(3/10) = 20 \log(e) - 5.23$$

$$10 \log(eirp) = EIRP[dBm] - 30$$

$$20 \log(e) = E[dB(\mu V / m)] - 120$$

$$EIRP = E - 120 + 30 - 5.23 = E - 95.23$$

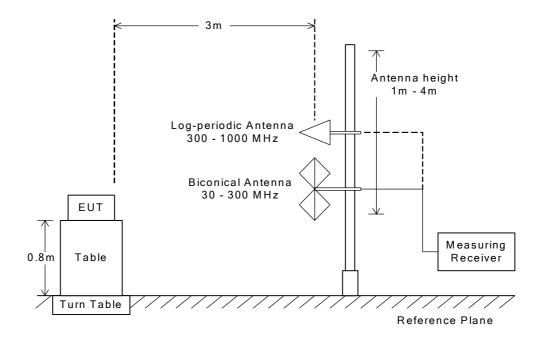
$$ERP[dBm] = EIRP - 2.15 = E - 97.38$$

The respective calculated ERP of the spurious and harmonics were compared with the ERP of fundamental frequency by specified attenuation limits, $43+10\log_{10}$ (TP in watt)[dB]. Where, TP = Transmitter power at the ANT OUT under test configuration as the hands free unit used.

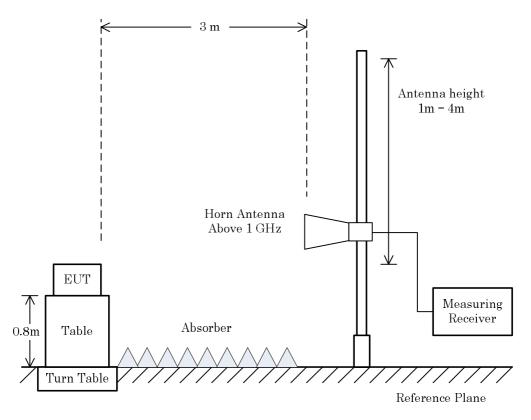


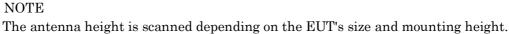
Radiated Emission 30 MHz to 1000 MHz

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Radiated Emission above 1 GHz

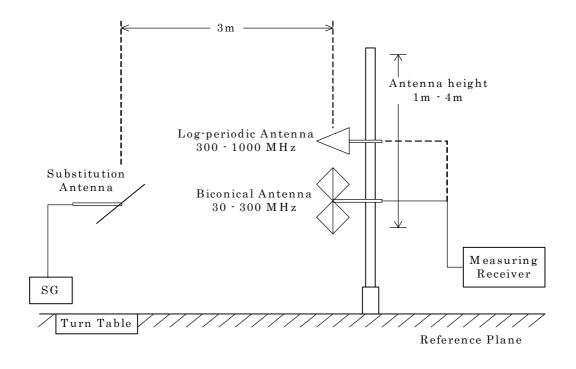






Radiated Emission 30 to 1000 MHz – Substitution Method

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7.7.4 Test Data

(GSM850)

Test Configuration : Single Unit

 Test Date: August 25, 2016

 Temp.: 26 °C, Humi: 70 %

Trans mitting Frequency				CRP Bm]	Limits [dBm]	Margin [dB]	Remarks
СН	[MHz]	[MHz]	Hori.	Vert.			
128	824.200	1648.400	-45.5	-45.4	-13.0	+32.4	С
		2472.600	-44.6	-45.1	-13.0	+31.6	С
		3296.800	< -55.0	< -55.0	-13.0	> +42.0	С
		4121.000	< -48.8	< -48.8	-13.0	> +35.8	С
		4945.200	< -48.0	< -48.0	-13.0	> +35.0	С
		5769.400	< -47.4	< -47.4	-13.0	> +34.4	С
		6593.600	< -45.2	< -45.2	-13.0	> +32.2	С
		7417.800	< -45.8	< -45.8	-13.0	> +32.8	С
		8242.000	< -42.6	< -42.6	-13.0	> +29.6	С
189	836.400	1672.800	-50.7	-50.4	-13.0	+37.4	С
		2509.200	-41.5	-41.8	-13.0	+28.5	С
		3345.600	< -54.8	< -54.8	-13.0	> +41.8	С
		4182.000	< -48.7	< -48.7	-13.0	> +35.7	С
		5018.400	< -47.8	< -47.8	-13.0	> +34.8	С
		5854.800	< -45.0	< -45.0	-13.0	> +32.0	С
		6691.200	< -45.3	< -45.3	-13.0	> +32.3	С
		7527.600	< -45.9	< -45.9	-13.0	> +32.9	С
		8364.000	< -42.5	< -42.5	-13.0	> +29.5	С
251	848.800	1697.600	-51.1	-50.7	-13.0	+37.7	С
		2546.400	-39.4	-40.1	-13.0	+26.4	С
		3395.200	< -54.6	< -54.6	-13.0	> +41.6	С
		4244.000	< -48.8	< -48.8	-13.0	> +35.8	С
		5092.800	< -47.6	< -47.6	-13.0	> +34.6	С
		5941.600	< -45.0	< -45.0	-13.0	> +32.0	С
		6790.400	< -45.3	< -45.3	-13.0	> +32.3	С
		7639.200	< -45.9	< -45.9	-13.0	> +32.9	С
		8488.000	< -42.6	< -42.6	-13.0	> +29.6	С



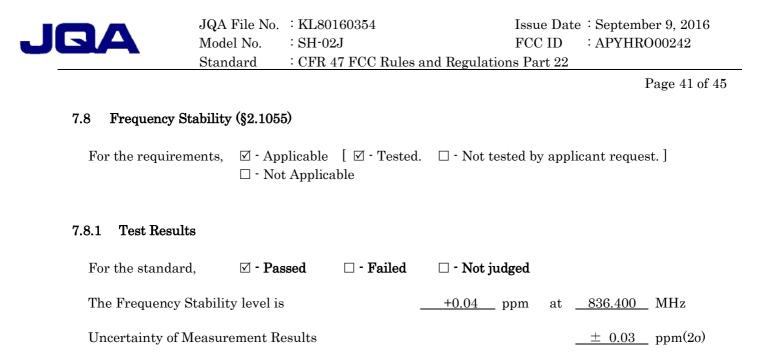
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Calculated result at 2546.4 MHz, as the worst point shown on underline: Minimum Margin: -13.0 - (-39.4) = 26.4 (dB)

NOTES

- 1. Test Distance : 3 m
- 2. The spectrum was checked from $30~\mathrm{MHz}$ to the tenth harmonic of the highest fundamental frequency.
- 3. All emissions not reported were more than 20 dB below the applied limits.
- 4. Applied limits : -13.0 [dBm] = $10\log(TP[mW]) \cdot (43 + 10\log(tp[W])) = 10\log(TP[mW]) \cdot (43 + (10\log(TP[mW]) \cdot 30))$ where, tp[W] = TP[mW] / 1000: Transmitter power at anttena terminal
- 5. The symbol of "<" means "or less".
- 6. The symbol of ">" means "more than".
- 7. Setting of measuring instrument(s) :

	Detector Function	RES B.W.	V.B.W.	Sweep Time
А	Peak	$10 \mathrm{kHz}$	30 kHz	20 msec.
В	Peak	$100 \mathrm{kHz}$	$300 \mathrm{kHz}$	20 msec.
С	Peak	1 MHz	3 MHz	20 msec.



Remarks :

7.8.2 Test Instruments

Shielded Room S4							
Туре	Model	Serial No. (ID)	Manufacturer	Cal. Due			
Base Station Simulator	CMU200	103210 (B-21)	Rohde & Schwarz	2017/05/29			
Environmental Chamber	SH-641	92010990 (F-32)	ESPEC	2017/07/13			
DC Voltage Meter	2011	02247S (B-33)	YOKOGAWA	2017/04/05			
DC Power Supply	NL035-10	35883293 (F-4)	TAKASAGO	N/A			

NOTE: The calibration interval of the above test instruments is 12 months.



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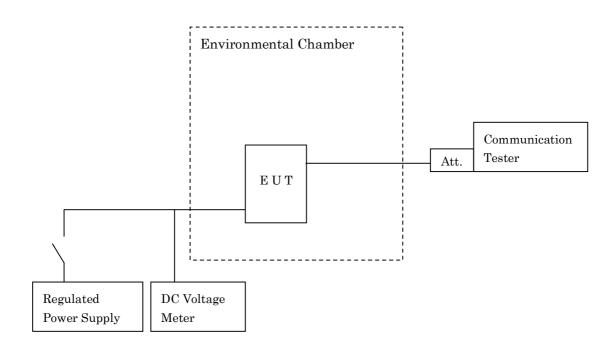
7.8.3 Test Method and Test Setup (Diagrammatic illustration)

Frequency Stability versus Temperature

The EUT was placed in an environmental chamber and was tested in the range from -30 to +50 degrees Celsius. The EUT was stabilized at each temperature. The power (4.0VDC) supplied was applied to the transmitter and allowed to stabilize for 10 minutes. The transmitting frequency was measured at startup and 2 minutes, 5 minutes and 10 minutes after startup. This procedure was repeated from -30 to +50 degrees Celsius at the interval of 10 degrees.

Frequency Stability versus Power Supply Voltage

The EUT was placed in an environmental chamber and was tested at the temperature of +20 degrees Celsius. The EUT was stabilized at the temperature. The power (4.0VDC) and the power (3.7VDC, the ending voltage) was applied to the EUT allowed to stabilize for 10 minutes. The transmitting frequency was measured at startup and 2 minutes, 5 minutes and 10 minutes after startup.





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7.8.4 Test Data

(GSM850)

<u>Test Date: August 30, 2016</u> - September 1, 2016

1. Frequency Stability Measurement versus Temperature

Transmitting Frequency DC Supply Voltage		: 836.400 MHz (1) : 4.0 VDC	89 ch)			
Ambient Temperature	Startup	Deviat 2 minutes	ion [ppm] 5 minutes	10 minutes	Limits [ppm]	Margin [ppm]
[°C]						
-30	+ 0.03	+ 0.03	+ 0.03	+ 0.03	2.50	2.47
-20	+ 0.03	+ 0.03	+ 0.03	+ 0.02	2.50	2.47
-10	+ 0.03	+ 0.03	+ 0.03	+ 0.03	2.50	2.47
0	+ 0.03	+ 0.03	+ 0.03	+ 0.03	2.50	2.47
10	+ 0.03	+ 0.03	+ 0.03	+ 0.03	2.50	2.47
20	+ 0.03	+ 0.03	+ 0.03	+ 0.03	2.50	2.47
30	+ 0.03	+ 0.03	+ 0.03	+ 0.03	2.50	2.47
40	+ 0.04	+ 0.03	+ 0.03	+ 0.03	2.50	2.46
50	+ 0.03	+ 0.03	+ 0.03	+ 0.03	2.50	2.47

2. Frequency Stability Measurement versus Power Supply Voltage

Transmitting Frequency Ambient Temperature : DC Supply		: 836.400 MHz (189 ch) : 20 °C Deviation [ppm] Limits				Margin
Voltage [V]	Startup	2 minutes	5 minutes	10 minutes	[ppm]	[ppm]
4.0 3.7(Ending)	+ 0.03 + 0.03	+ 0.03 + 0.03	+ 0.03 + 0.03	+ 0.03 + 0.03	2.50 2.50	2.47 2.47

 Test condition example as the maximum deviation point shown on underline:

 Ambient Temperature
 : 40 °C / Startup

 DC Supply Voltage
 : 4 VDC

 Minimum Margin: 2.50 - 0.04 = 2.46 (ppm)

 NOTE : The measurement were made after all of components of the oscillator sufficiently stabilized at each temperature.